


<b>Search Notes</b>  	<b>Application/Control No.</b>  10792322	<b>Applicant(s)/Patent Under Reexamination</b>  LEE ET AL.
	<b>Examiner</b>  Liu, Li	<b>Art Unit</b>  2613

SEARCHED			
Class	Subclass	Date	Examiner
398	19-34, 66-79	11/29-12/05, 2006	LL
385	24-27	11/29-12/05, 2006	LL
359	124-135	11/29-12/05, 2006	LL

SEARCH NOTES		
Search Notes	Date	Examiner
EAST: US-PGPUB, USPAT, JPO, EPO, DERWENT, IBM_TDB	11/29-12/05, 2006, 5/17/2007, 10/12-10/13, 2007	LL
IEEE	11/29/2006, 10/12/2007	LL
GOOGLE	11/29/2006, 10/12/2007	LL
PLUS	5/17/2007	LL

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner